

Search Notes

Application/Control No.

10/760,669

Examiner

Tianjie Chen

Applicant(s)/Patent under
Reexamination

SBIAA, RACHID

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner
360	324.11		
	324.1		
	324.12		
	324		
	322	10/6/2006	TJ

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Report	10/6/2006	TJ